

# Search Notes



Application/Control No.

10/608,914

Examiner

Emmanuel Bayard

Applicant(s)/Patent under Reexamination

AGRAWAL, AVNEESH

Art Unit

2638

## SEARCHED

Class	Subclass	Date	Examiner
375	132	12/1/05	2-13
375	135		
375	130		
370	350		
370	341		
370	329		2-13
455	428		2-13
455	103	12/12/05	2-13

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
2-13	12/1/05	2-13